Workshop on In Situ Methods in Nanomechanics

August 1-3, 2007

Lawrence Berkeley National Laboratory Berkeley, California, USA

Organizers:

Andrew M. Minor (Lawrence Berkeley National Laboratory)
Oden L. Warren (Hysitron, Inc.)

Sponsors:









Day 1: Wednesday, August 1

Location: The Claremont Resort & Spa, Berkeley (Lanai 2)

<u>Time</u> <u>Speaker/Event</u>

7:00-8:30 Opening reception (sponsored by JEOL)

Day 2: Thursday, August 2

Location: Lawrence Berkeley National Laboratory (Building 66 Auditorium)

<u>Time</u> 8:30	Speaker/Event Bus departure from The Claremont Resort & Spa to the Workshop
9:00-9:10	Welcome address (by hosts, organizers)
9:10-9:40	PLENARY: William Nix, Stanford University The need for in situ observations of plastic deformation at the sub- micrometer scale
9:40-10:00	Jack Houston, Sandia National Laboratories An in-situ SEM/IFM combination for studies of the mechanical properties of individual nanostructures
10:00-10:20	Vikas Prakash, Case Western Reserve University In situ mechanical characterization of individual micro-/nano-scale fibers

10:20-10:40	Coffee break
10:40-11:00	INVITED : Daryl Chrzan, University of California, Berkeley and Lawrence Berkeley National Laboratory Novel materials deforming near their ideal strength
11:00-11:20	Rod Ruoff, University of Texas at Austin Tensile loading known (n,m) SWCNTs and mechanics of 'graphene oxide paper'
11:20-11:40	Jianyu Huang, Sandia National Laboratories In-situ plastic deformation of carbon nanotubes
11:40-12:00	Syed Asif, Hysitron, Inc. The role of surface forces and tip-surface interaction on the onset of plasticity
12:00-1:00	Onsite lunch
1:00-1:30	INVITED: Aman Haque, Penn State University MEMS-based tools for in-situ nanomechanical testing
1:30-1:50	Scott Mao, University of Pittsburgh In-situ TEM study on deformation and fracture of nanocrystalline materials
1:50-2:10	Nathan Mara, Los Alamos National Laboratory In-situ observation of superplasticity and cooperative grain boundary sliding in nanocrystalline Ni ₃ Al
2:10-2:30	Donna Ebenstein, Bucknell University Correlating nanomechanical properties with chemical composition and surface morphology in silk films using micro-Raman spectroscopy and stiffness imaging
2:30-2:50	Coffee break
2:50-3:20	INVITED: Kathryn Wahl, US Naval Research Laboratory <i>In situ tribology: What's really happening in the buried sliding interface?</i>
3:20-3:40	Daan Hein Alsem, Lawrence Berkeley National Laboratory Nanoscale tribology of polycrystalline silicon structural films
3:40-4:00	Laurence Marks, Northwestern University Friction in Full View

4:00-4:30	INVITED: Dominique Hubert, FEI Co. New developments in aberration corrected S/TEM microscopy: A new era for in-situ structure-property relationships studies
4:30-5:30	Poster session
5:30	Bus departure from the Workshop to The Claremont Resort & Spa
6:45	Bus departure from The Claremont Resort & Spa to the offsite dinner
7:00-9:00	Offsite dinner
9:00	Bus departure from the offsite dinner to The Claremont Resort & Spa

Day 3: Friday, August 3

Location: Lawrence Berkeley National Laboratory (Building 66 Auditorium)

<u>Time</u> 8:30	Speaker/Event Bus departure from The Claremont Resort & Spa to the Workshop
9:00-9:30	KEYNOTE: Helena Van Swygenhoven, Paul Scherrer Institute <i>In-situ micro-compression in the Swiss Light Source</i>
9:30-9:50	Zhiwei Shan, Hysitron, Inc. Perfecting nanostructural single crystal Ni through stress/strain annealing
9:50-10:10	Jia Ye, Lawrence Berkeley National Laboratory Quantitative in-situ TEM nano-compression tests of AA6063 aluminum alloys
10:10-10:30	Coffee break
10:30-11:00	INVITED: John Balk, University of Kentucky In situ observations of deformation during indentation of nanoporous gold thin films
11:00-11:20	Takahito Ohmura, National Institute for Materials Science Observation of dislocation-grain boundary interactions in martensitic steel through in-situ nanoindentation in a TEM
11:20-11:40	Lars Johnson, Linköping University In situ TEM nanoindentation studies of alpha-Al ₂ O ₃ and Ti ₃ SiC ₂

11:40-12:00	Michel Barsoum, Drexel University On the determination of spherical nanoindentation stress-strain curves and their importance
12:00-1:00	Onsite lunch
1:00-1:30	INVITED: Simon Ruffell, Australian National University <i>In-situ electrical characterization during nanoindentation in silicon</i>
1:30-1:50	Dylan Morris, National Institute of Standards and Technology Multi-scale measurement of contact forces and current with a custom adhesion apparatus
1:50-2:10	Ryan Major, Hysitron, Inc. Conductive nanoindentation: In-situ correlation of mechanical properties, deformation behavior, and electrical characteristics of materials
2:10-2:40	INVITED: Thomas LaGrange, Lawrence Livermore National Laboratory Application of time-resolved transmission electron microscopy to in situ deformation studies
2:40-3:00	Mitra Taheri, Lawrence Livermore National Laboratory An environmental stage for the dynamic TEM: In situ microstructural evolution in varied atmosphere at nanosecond scales
3:00-4:30	Lab tour of the National Center for Electron Microscopy (Building 72)
3:15	Bus departure from the Workshop to The Claremont Resort & Spa for those unable to participate in the lab tour
4:30	Bus departure from the Workshop to The Claremont Resort & Spa for those able to participate in the lab tour